

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of:)
Shin IKEDA et al.) Group Art Unit: 1643
Serial No.: To Be Assigned) Examiner: A. NOGUEROLA
(R53(b)DIV of SN: 09/424,715))
Filed: December 21, 2001)
For: METHOD FOR DETERMINING SUBSTRATE)

jc971 U.S. PTO
10/023734
12/21/01

INFORMATION DISCLOSURE STATEMENT

Hon. Assistant Commissioner for Patents
Washington, D.C. 20231

Sir:

In accordance with 37 C.F.R. § 1.56, the attention of the Patent and Trademark Office is directed to the cited references listed on the attached PTO-1449. The cited references listed were cited by or submitted to the U.S. Patent and Trademark Office in the currently pending predecessor application Serial No. 09/424,715, filed on November 29, 1999, the priority of which is being hereby claimed under 35 U.S.C. § 120. Accordingly, copies of the references are not enclosed.

Respectfully submitted,
MCDERMOTT, WILL & EMERY

Dated: _____

12/21/01

By: _____

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**INFORMATION DISCLOSURE
CITATION IN AN
APPLICATION**

(PTO-1449)

ATTY. DOCKET NO.

43888-122

SERIAL NO.

To Be Assigned

APPLICANT

Shin IKEDA, et al.

FILING DATE

November 21, 2001

GROUP

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10/023734

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U.S. PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NO.	DATE	NAME	CLASS	SUBCLASS	FILING DATE
	5,582,697	12-1996	Ikeda et al.	204	403	

FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						Yes	No
	8-320304	12/3/96	Japan				
	5-340915	12/24/93	Japan				
	2-310457	12/26/90	Japan				
	9-101280	4/15/97	Japan				
	3-54447	3/8/91	Japan				
	6-109693	4/22/94	Japan				
	10-19832	1/23/98	Japan				
	9-201337	8/5/97	Japan				

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER

DATE CONSIDERED

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.